


<b>Search Notes</b>  	<b>Application/Control No.</b>  10830175	<b>Applicant(s)/Patent Under Reexamination</b>  HOULDING ET AL.
	<b>Examiner</b>  YI CHEN	<b>Art Unit</b>  2142

SEARCHED			
Class	Subclass	Date	Examiner
709	226	9/11/2008	Yi Chen

SEARCH NOTES		
Search Notes	Date	Examiner
Full text search of US patents, US-pubs, and EPO, JPO, Derwent and IBM-TDB databases	9/12/2008	Yi Chen
Inventor name search	9/12/2008	Yi Chen
Searched inventors	9/12/2008	Yi Chen

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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